

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

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10/618,018

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Satoshi FUJIMINE, et al.

FILING DATE

July 14, 2003

GROUP

2873

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>MM</i>	AA	6,617,789	09/09/2003	H. ONODA, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AB	6,497,962	12/24/2002	S. FUJIMINE, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AC	6,419,540	07/16/2002	H. TANAKA, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AD	6,160,345	12/12/2000	H. TANAKA, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AE	2002/0034917 A1	03/21/2002	H. TANAKA, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AF	2002/0036466 A1	03/28/2002	H. TANAKA, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AG	6,376,400	04/23/2002	S. FUJIMINE, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AH	6,355,586	03/12/2002	H. USUI, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AI	5,948,537	09/07/99	H. ONODA, et al.	<i>11</i>	<i>11</i>	
<i>MM</i>	AJ	5,714,840	02/03/98	R. TANABE, et al.	<i>11</i>	<i>11</i>	
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>MM</i>	AO	WO 02/102733	12/27/2002	WIPO (with English Abstract)		X
<i>MM</i>	AP	2001-139345	05/22/2001	JAPAN (with English Abstract)		X
<i>MM</i>	AQ	2000-313637	11/14/2000	JAPAN		X
<i>MM</i>	AR	11-25865	01/29/99	JAPAN (with English Abstract)		X
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

*Robert J. Zimmerman*

Date Considered

*10/12/04*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.